## Notice of References Cited Application/Control No. 09/941,142 Examiner David J. Huisman Applicant(s)/Patent Under Reexamination WAH CHAN ET AL. Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-5,420,991	05-1995	Konigsfeld et al.	711/150
*	В	US-6,141,734	10-2000	Razdan et al.	711/144
	O	US-			
	۵	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	-	US-			
	J	US-			
	κ	US-			
	اد	US-			
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Ν				•	
	0					
	Р					
	σ					,
	R					,
	Ø					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)						
	٥							
	>							
	>							
	×							

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.